# Technologies Network Analyzer Selection Guide



#### По вопросам продаж и поддержки обращайтесь:

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### Gain Deeper Confidence

Whether you're testing active or passive components, the right mix of speed and performance gives you an edge. In R&D, our vector network analyzers (VNAs) provide a level of measurement integrity that helps you transform deeper understanding into better designs. On the production line, our cost-effective VNAs provide the throughput and repeatability you need to transform parts into competitive components. Every Technologies, Inc. VNA is the ultimate expression of our expertise in linear and nonlinear device characterization. On the bench, in a rack or in the field, we can help you gain deeper confidence.

#### Physical measurement ecosystem



### **VNA Solutions**

offers a variety of vector network analyzers with frequency, performance, and versatility to meet your measurement needs.

To help you determine which solution is right for you, this selection guide provides an overview and side-by-side comparison of all our network analyzers. In addition, you will find typical network analyzer applications, the measurement needs for those applications, and how Keysight's network analyzers meet those needs.

	Model		Typical application	Frequency range
		N524xA PNA-X Series Most advanced and flexible VNA	<ul> <li>Replace an entire rack of equipment with one instrument</li> <li>Complete linear and nonlinear active device characterization</li> </ul>	<ul> <li>10 MHz to 8.5/13.5/26.5/</li> <li>43.5/50/67 GHz</li> <li>Up to 1.1 THz with extenders</li> </ul>
PNA Family Reach for unrivaled excellence		N522xA PNA Series High performance microwave VNA	<ul> <li>Highest performance passive component analysis</li> <li>Active components characterization</li> <li>Metrology and cal lab</li> </ul>	<ul> <li>10 MHz to 13.5/26.5/ 43.5/50/67 GHz</li> <li>Up to 1.1 THz with extenders</li> </ul>
		N523xA PNA-L Series Economy microwave VNA	<ul> <li>Microwave S-parameter test</li> <li>Signal integrity</li> <li>Material measurements</li> </ul>	<ul> <li>300 kHz to 8.5/13.5/</li> <li>20 GHz</li> <li>10 MHz to 43.5/50 GHz</li> </ul>
-		<b>E5080A ENA</b> High performance RF VNA with modern GUI	<ul> <li>RF component test</li> <li>High-rejection filter test</li> <li>Multiport module test</li> </ul>	– 9 kHz to 4.5/6.5/9 GHz
		<b>E5072A ENA</b> High performance RF VNA with configurable test set	<ul> <li>RF amplifier test</li> <li>High-power RF component test</li> <li>PIM measurements</li> </ul>	<ul> <li>- 30 kHz to 4.5/8.5 GHz</li> </ul>
<b>ENA</b> Drive down the cost of test		E5071C ENA High performance RF VNA	<ul> <li>RF component test</li> <li>Multiport module test</li> <li>Material measurements</li> <li>Signal integrity</li> </ul>	<ul> <li>9 kHz to 4.5/6.5/8.5 GHz</li> <li>300 kHz to 14/20 GHz</li> </ul>
		<b>E5061B ENA</b> LF-RF VNA with impedance analysis function Low cost RF VNA	<ul> <li>LF component/circuit test</li> <li>Component Z evaluation</li> <li>RF component test</li> <li>CATV component test</li> </ul>	<ul> <li>5 Hz to 3 GHz</li> <li>100 kHz to 1.5/3 GHz</li> </ul>
		E5063A ENA Low-cost RF VNA for passive component test	<ul> <li>Antenna manufacturing test</li> <li>RF passive component test</li> <li>Material measurements</li> <li>PCB manufacturing test</li> </ul>	– 100 kHz to 4.5/8.5/18 GHz
<b>PXI VNA</b> Drive down the size of test		<b>M937xA PXI VNA Series</b> Full two-port VNA that fits in just one slot	<ul> <li>Antenna manufacturing test</li> <li>RF component test</li> <li>Multiport module test</li> <li>Multi-site test</li> </ul>	- 300 kHz to 4/6.5/ 9/14/20/ 26.5 GHz
<b>FieldFox</b> Carry precision with you		N99xxA FieldFox Analyzers Handheld combination, VNA and spectrum analyzer	<ul> <li>Field test</li> <li>S-parameters</li> <li>Cable and antenna test</li> <li>Line sweeping</li> <li>Radio compliance tests</li> <li>Interference hunting</li> </ul>	<ul> <li>30 kHz to 4/6.5/9/14/18/26.5 GHz</li> <li>300 kHz to 32/44/50 GHz</li> </ul>

### Active Component Evaluation and Test

#### Measurement challenges

network analyzers can be used to characterize and test active com-ponents, such as amplifiers, mixers, and frequency converters. They can easily measure commonly specified amplifier parameters such as gain, gain and phase compression, isolation, return loss, and group delay. Harmonic distortion is often used to understand an amplifier's nonlinear behavior, and requires the receiver to be tuned at a different frequency from the source. Frequency-translating devices, such as mixers and frequency converters present unique measurement challenges because their input and output frequencies are different. Network analyzers used for testing these devices need to have a frequency-offset mode (FOM) to detect output frequencies different from the input. Additional instruments and signal conditioning devices may be required for testing with two-tone, higher input and output power, or for other types of measurements including noise figure, ACPR, and EVM. As a result, the test system becomes complicated or requires multiple stations.

#### Our solutions

offers a wide range of flexible and affordable test solutions for vector network analysis of active components. Keysight's VNAs are designed for linear and nonlinear characterization with the highest accuracy. In addition to high performance, a variety of measurement applications simplifies setup, reduce test time, and improve measurement accuracy.



#### Key features

- Amplifier gain, match and isolation: S-parameter measurements
- AM-AM and AM-PM conversion: power sweep, source and receiver calibration
- High power/pulse configurability: configurable test set, high output power, source and receiver attenuators,

internal pulse generators, external pulse generator control, internal pulse modulators

- Frequency-converter conversion gain/loss: FOM, source and receiver calibration, scalar mixer calibration
- Frequency-converter conversion phase/group delay: FOM, magnitude and phase calibration, vector mixer calibration
- LO drive/measurements: second internal source, external RF source control, 3-port calibration and measurements, LO power calibration

- Mixer topology: swept-RF, swept/fixed-LO (fixed-IF/swept-IF), dual-stage converter, converter with embedded LO
- Accurate source power output and absolute power measurements: source and receiver calibration, power-sensormismatch correction, receiver leveling
- Harmonic distortion: FOM, source and receiver calibration, low source harmonics, receiver attenuator
- Intermodulation-distortion (IMD): FOM, second internal source, external source control, internal combining network, swept-IMD
- Noise figure measurements
- Hot-S22 measurements: FOM, second internal source, internal combining network
- Power-added efficiency: DC inputs and/or DC meter control
- DC bias: internal DC bias source/DC source control/internal bias-tee
- Nonlinear vector network analysis (NVNA): waveform analysis, X-parameters

### Active Component Evaluation and Test (continued)

Models						Features					
	Ampli- fier gain, match, isolation	Ampli- fier AM-AM, AM-PM conversion	High-power configure- ability <sup>1</sup>	Pulse	DC bias/ DC input	FOM, conversion gain/loss/ phase/group delay	Setup wizard/ Quick start	Active measurement applications <sup>2</sup>	Two internal sources	Internal com- biner/path switches	NVNA
PNA-X	٠	•	•	•	•	•	٠	٠	•	•	٠
PNA	•	•	•	٠	•	٠	٠	•	•7		
PNA-L	٠	•	● <sup>3</sup>	•4		•6	٠				
E5080A	•	•		•4	•	•	٠				
E5072A	•	•	•3	•4	•	•	٠				
E5071C	•	•		•4	•	•	٠				
E5061B LF	•	•		•4	•5						
E5061B RF	•	•		•4							
FieldFox	٠				•5	•8					

1. Includes configurable test set, high-output power, source attenuator, and receiver attenuator

#### Includes swept-frequency gain compression, two-tone IMD, pulse, noise figure measurements for amplifiers and frequency converters

3. Receiver attenuator not available

- 4. Requires external pulse generators and modulators
- 5. Built-in DC bias source, no bias tee
- 6. Conversion phase/group delay not available
- 7. Requires 4-port PNA
- 8. Scalar FOM using USB power sensor or spectrum analyzer functionality



# Typical solutions

#### Most integrated and flexible

N524xA PNA-X Series microwave network analyzer

- 10 MHz to 8.5/13.5/26.5/43.5/50/67 GHz, 2- or 4-ports
- Two internal sources with low harmonics, combining network, and pulse generators/modulators
- Internal path configuration switches for multiple measurements with a single connection
- Amplifier and converter applications for simple setup, faster measurements and improved accuracy

#### Highest performance

N522xA PNA Series microwave network analyzer

- 10 MHz to 13.5/26.5/43.5/50/67 GHz, 2- or 4-ports
- Two internal sources (4-port only) and pulse generators/modulators
- Highest RF performance and accuracy
- Amplifier and converter applications for simple setup, faster measurements and improved accuracy

#### RF standard with flexibility

E5080A ENA Series network analyzer

- 9 kHz to 4.5/6.5/9 GHz, 2- or 4-port -

- Wide power sweep range (-90 to +15 dBm)
- Frequency Offset Mode, Scalar Mixer measurement, and Vector Mixer Characterization





### Passive Component Evaluation and Test



#### Measurement challenges

For quality communications systems, high performance passive devices such as filters, combiners, switches, and transmission lines often require low ripple and low insertion loss in the pass band, and high rejection ratios in the stop band. Devices are sometimes used in balanced circuits and therefore have multiple input and output ports that complicate measurement-system configurations. For these devices, the key measurement challenge is to easily get accurate data, as fast as possible. Wide measurement-frequency range is required to characterize multi-band operation.

#### Our solutions

VNAs have a broad frequency range; from 5 Hz to 1.1 THz. Low trace noise, advanced calibration techniques, and good stability help evaluate your passive components with the required accuracy. VNAs with a configurable test set allow direct receiver access, improving system dynamic range for more accurate and faster device measurements. Multiple traces can be displayed in different formats, and various marker searches including filter parameters and trace-math functions are available for easy analysis.

Accurate measurements of low insertion loss and low ripple require a VNA with low trace noise and high stability.





#### Key features

- Wide dynamic range: fast and accurate filter measurements
- Wide frequency range: covers inand out-of-band characteristics
- Direct receiver access: obtain widest possible dynamic range
- Low-cost solution: just enough performance and function for your test
- Low trace noise and high stability: high quality device measurements
- Unknown-thru calibration: easy and accurate non-insertable device measurements
- Adapter removal/characterization: accurate mixed-connector device measurements
- Balanced S-parameter measurements: accurate measurements without balun

- Multiport/Multi-site solutions: easy multiport or multiple DUT evaluation
- Full N-port calibration: mismatchcorrected accurate multiport measurements
- Metrology option: highest accuracy and stability for metrology-grade component evaluation
- Time domain analysis/gating function: troubleshooting and simple simulation
- Trace analysis functions using marker and trace math

### Passive Component Evaluation and Test (continued)

Models					Feat	ures					
	MIN/MAX frequency in the series	Wide dynamic range (dB)	Extended dy- namic range by direct receiver access	Afford- able cost	Trace noise at 1 kHz IFBW (dB rms) <sup>1</sup>	Unknown thru calibration	Adapter removal/ character- ize function	Balanced S- parameters	Multiport solutions	Max # of full-port cal	Metrology option
PNA-X	10 MHz/67 GHz	> 130	•		0.002	•	•	•	•	> 4	
PNA	10 MHz/67 GHz	> 130	•		0.002	•	•	•	٠	> 4	٠
PNA-L	300 kHz/50 GHz	> 130	•	•	0.004	•	•	•	٠	> 4	
E5080A	9 kHz/9 GHz	> 135		•	0.0005	•	•	•	٠	4	
E5072A	30 kHz/8.5 GHz	> 120	٠		0.0005	•	•			2	
E5071C	9 kHz/20 GHz	> 120		•	0.0004	•	•	•	٠	4	
E5061B LF	5 Hz/3 GHz	> 120			0.003		٠			2	
E5061B RF	100 kHz/3 GHz	> 120		٠	0.003		٠			2	
E5063A	100 kHz/18 GHz	> 115		•	0.0006	•	•			2	
PXI VNA	300 kHz / 26.5 GHz	> 115		•	0.003	•	•	•	•	Up to 32	
FieldFox	30 kHz/50 GHz	> 95		٠	0.004 <sup>3</sup>	٠		٠		2	

1. Calculated based on the specification at different IFBW settings

2. 1-port differential measurements

3. Trace noise at 1 GHz with 300 kHz IFBW









### Typical solutions

#### Best accuracy up to microwave frequencies

N522xA PNA Series network analyzer

- 10 MHz to 13.5/26.5/43.5/50/67 GHz, 2- or 4-ports
- Wide dynamic range (> 128 dB at 26.5 GHz, > 112 dB at 67 GHz)
- World's highest accuracy. Metrology option for ultimate S-parameter measurements.
- Full N-port calibration support
- Up to 1.1 THz by using millimeter-wave frequency extenders

#### Best accuracy for RF passive component test

E5080A ENA Series network analyzer

- 9 kHz to 4.5/6.5/9 GHz, 2- or 4-ports
- Wide dynamic range (135 dB spec, 147 dB typical)
- Excellent trace noise (0.0015 dBrms with IFBW=10 kHz) and stability (0.005 dB/°C)

#### Best balance between price and performance

E5063A ENA Series network analyzer

- 100 kHz to 4.5/8.5/18 GHz
- > 117 dB dynamic range
- PCB test function

#### Easy to reconfigure based on test needs

M937xA PXI VNA Series

- 300 kHz to 4/ 6.5/ 9/ 14/ 20/ 26.5 GHz
- Best PXI VNA performance on key specifications such as dynamic range, measurement speed, and trace noise
- Up to 16 full 2-port VNA modules in a single chassis
- Full N-port calibration support

### General Purpose, Education







#### Measurement challenges

General-purpose RF network analyzers are essential in education institutions and many other RF labs. Users typically require measurements of S-parameters, power, and sometimes material parameters, for a broad range of passive and active components, with both single-ended and differential inputs and outputs. Devices typically have 2-, 3- and sometimes 4-ports, and must be measured in coaxial, in-fixture, or on-wafer environments. Active devices like amplifiers, mixers, and frequency-converters often require considerable time to measure all necessary parameters. Test equipment is not used every day and is often shared with other groups.

#### Our solutions

has a wide range of general-purpose VNAs, from powerful yet economical benchtop models covering the frequency range of a few GHz up to 100's of GHz, to handheld models that are easily shared and give results on par with their benchtop equivalent.

- ENA and PNA-L benchtop models offer excellent speed and accuracy at affordable prices
- PNA offers the highest S-parameter accuracy and can be used with millimeter-wave extenders up to 1.1 THz
- PXI VNA offers best PXI performance using only a single slot in modular test solutions
- Guided calibration wizards and ECal modules make calibration easy
- FieldFox's portability makes it easy to share among different groups

#### Key features

- 4-port models make it easy to test couplers, circulators, splitters, and other
   3- and 4-port devices, as well as balanced/differential components
- ECal modules replace mechanical calibration kits making calibration fast and easy to perform, and much less prone to operator errors
- Power-meter-based calibration yields accurate measurements of DUT input and output power over a very broad range of powers
- Built-in support for port extensions, port matching, deembedding, and impedance transformations extends coaxial accuracy to on-wafer and in-fixture measurements
- Offsetting the frequency of the source and receivers allows measurements of mixers and frequency converters
- External millimeter-wave modules extend the frequency of operation up to 1.1 THz
- Materials measurement software offers full characterization of dielectric properties using a variety of measurement methods

### General Purpose, Education (continued)

Models	Features												
	2-port models	4-port models	ECal support	Power meter cal	Frequency offset mode	Probe, fixture features	Support for mm-wave modules	Spectrum analysis and independent source					
PNA-X	•	•	•	•	٠	•	•	•					
PNA	٠	•	٠	٠	٠	٠	٠	٠					
PNA-L	•	•1	٠	•	•	•							
E5080A	•	•	•	٠	٠	•							
E5072A	•		٠	•	•	•							
E5071C	•	•	•	٠	•	•							
E5061B LF	•		•										
E5061B RF	•		٠										
E5063A	•		•										
PXI VNA	•	•2	•			•							
FieldFox	•		•		• <sup>3</sup>			•					

1. 13.5 and 20 GHz models only

2. Add additional 2-port modules to achieve up to 32-ports in a single chassis

3. Scalar FOM using USB power sensor or spectrum analyzer functionality



### Typical solutions

#### Best value for microwave S-parameter measurements

N523xA PNA-L Series microwave network analyzer

- 300 kHz to 8.5/13.5/20 GHz, 10 MHz to 43.5/50 GHz, 2-ports
- 300 kHz to 13.5/20 GHz 4-ports
- Basic S-parameters and materials measurements



#### Unsurpassed accuracy in S-parameter measurements

N522xA PNA Series microwave network analyzer

- 10 MHz to 13.5/26.5/43.5/50/67 GHz, 2- or 4-ports
- Wide dynamic range (> 128 dB at 26.5 GHz, > 112 dB at 67 GHz)
- Linear and non-linear measurement options
- Up to 1.1 THz using millimeter-wave frequency extenders



#### The best-in-class performance and advanced usability

E5080A ENA Series network analyzer

- 9 kHz to 4.5/6.5/9 GHz, 2- or 4-port
- Wide dynamic range (135 dB spec, 147 dB typical)
- Modern GUI

### General Purpose, Education (continued)



#### Easy to reconfigure based on test needs

M937xA PXI VNA Series

- 300 kHz to 4/ 6.5/ 9/ 14/ 20/ 26.5 GHz
- Best PXI VNA performance on key specifications such as dynamic range, measurement speed, and trace noise
- RF and microwave balanced devices
- Full N-port calibration support



#### Easily shared tool for quick evaluations

N991xA/N995xA FieldFox handheld microwave (combination) analyzers<sup>1</sup>

- 30 kHz to 4/6.5/9/14/18/26.5 GHz for N991xA
- 300 kHz to 32/44/50 GHz for N995xA
- T/R (S11/S21) or full 2-port S-parameters
- Spectrum analyzer function
- Independent source and tracking generator
- 1. Combination analyzer = Cable and antenna tester (CAT) + Vector network analyzer (VNA) + Spectrum analyzer (SA)

### Manufacturing



#### Measurement challenges

Driving down the cost of test is the key challenge in manufacturing, and there are multiple factors that influence this. One key factor is throughput. The measurement time of a VNA can be divided into several different contributions such as sweep speed, data analysis, display processing, and data transfer. In many cases, the analyzer must send pass/fail results to an automated system. The sweep speed and data-analysis speed are critical for high-volume manufacturing. Being able to minimize the amount of operator intervention, as well as connection and calibration times will also affect measurement throughput. Initial procurement cost, system uptime, maintenance costs, and future performance upgrade costs for test stations also affect total cost of ownership.

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#### Our solutions

offers a broad range of VNAs with very fast data-acquisition speeds and excellent repeatability due to low trace noise and high temperature stability – essential elements to optimize manufacturing test. Many VNAs are equipped with a parts-handler interface to achieve fast throughput on an automated production line. You can find the optimum VNA for your manufacturing environment, and only pay for the capabilities you need to minimize your initial procurement costs.



#### Key features

- Fast processors and wide bandwidths: very fast data acquisition speeds
- Fast data-transfer speeds for maximum throughput
- Segment sweeps: faster testing by tailored stimulus conditions
- Pass/fail limit testing: easy and fast data analysis on the VNA
- Test fixture deembedding: measure device's true performance
- Internal programming capability: customize VNA operation and data analysis

- ECal modules: simple and fast calibration
- Parts-handler interface: fast handshaking with an ATE system
- Multiport/Multi-site solutions: multiple and multiport device test with minimal connections
- Direct-receiver access: obtain widest possible dynamic range
- Upgradable processors: keep your instrument up-to-date
- Hardware upgrade paths: support your evolving measurement needs

# Manufacturing (continued)

Models						Features					
	Fast data process & transfer	Segment sweeps	Pass/ fail limit testing	Test fixture deembedding	Built-in programming capability	ECal support	Parts handler interface	Multiport/ Multi-site solutions	Direct receiver access	Hardware upgrade	Processor upgrade
PNA-X	•	•	•	٠		•	•	٠	•	•	•
PNA	•	•	•	٠		٠	•	٠	•	•	•
PNA-L	•	•	•	٠		•	•	٠	•	•	•
E5080A	•	•	٠	٠		•	•	٠		•	
E5072A	•	•	٠	٠	٠	•	•		•	•	
E5071C	•	•	•	٠	٠	•	•	٠		•	•
E5061B LF	•	•	•		•	•	•				
E5061B RF	•	•	•		•	•	•			•	
E5063A	•	•	•	٠		•	•			•	
PXI VNA	•	•	•	•	•1	•		•		•	• <sup>2</sup>
FieldFox			•			•					

1. Programming capability is available in the embedded or external controller used to control the PXI VNA module.

The central processor for this instrument is the embedded or external controller, which is upgradable.









### Typical solutions

#### The standard in RF manufacturing test

E5080A ENA Series network analyzer

- 9 kHz to 4.5/6.5/9 GHz, 2- or 4-ports
- Fast measurement speed
- Wide dynamic range (135 dB spec, 147 dB typical)
- Excellent trace noise (0.0015 dBrms with IFBW=10 kHz) and stability (0.005 dB/°C)

#### Best balance between price and performance

E5063A ENA Series network analyzer

- 100 kHz to 4.5/8.5/18 GHz
- > 117 dB dynamic range
- 0.006 dB rms trace noise
- PCB test function

### Best value for microwave manufacturing

N523xA PNA-L Series microwave network analyzer

- 300 kHz to 8.5/13.5/20 GHz, 10 MHz to 43.5/50 Hz, 2-ports
- 300 kHz to 13.5/20 GHz, 4-ports
- Wide frequency range up to 50 GHz

#### Easy to reconfigure based on test needs

M937xA PXI VNA Series

- 300 kHz to 4/ 6.5/ 9/ 14/ 20/ 26.5 GHz
- Best PXI VNA performance on key specifications such as dynamic range, measurement speed, and trace noise
- Up to 16 full 2-port VNA modules in a single chassis
- Full N-port calibration support

### High-Speed Serial Interconnect Analysis



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#### Measurement challenges

As data rates of digital systems increase, signal integrity of interconnects drastically affects system performance. The effects of physical layer components such as printed circuit board traces, connectors, cables, and IC packages can no longer be ignored. Fast and accurate analysis of interconnect performance in both time and frequency domains become critical to ensure reliable system performance. Because managing multiple test systems becomes difficult, a single test system that can fully characterize differential high-speed digital devices is a very powerful tool.

#### Our solutions

#### N1930B Physical Layer Test System (PLTS)

- Automatic Fixture Removal (AFR) for accurate, yet simple error correction and deembedding of unwanted structures inside channel path
- Channel simulator provides user-defined pre-emphasis and equalization settings for real-world channel analysis
- MATLAB interface allows many aspects of testing to be customized and automated which typically cuts test-plan development in half
- Characterization report details all critical DUT performance parameters along with specific test-system information to archive important technical test-plan data

#### E5071C ENA Option TDR

- Similar look-and-feel to traditional TDR oscilloscopes, for simple and intuitive operation
- Easily locate source of loss, reflections and crosstalk by simultaneous analysis of both time and frequency domains
- Internal protection circuits inside the instrument provide high robustness against electrostatic discharge (ESD)
- Determine optimal emphasis and equalization settings for your link
- Simulate real-world signals through jitter insertion
- Analyze impedance of active devices under actual operating conditions (Hot TDR) to quantify the multiple reflection effect

#### High-speed serial interconnect analysis

Models		Features										
	Maximum bandwidth	Maximum # of ports	Frequency domain	Time domain	Eye diagram	Stressed eye diagram analysis	Hot TDR	Compliance test (MOI) <sup>1</sup>	Real-time analysis	Advanced error correction methods <sup>2</sup>		
PLTS	Up to 67 GHz	Up to 16	•	•	•	•	•			•		
ENA Option TDR	Up to 20 GHz	Up to 4	•	•	٠	٠	٠	٠	٠			

1. PLTS has automated test suite templates that assist R&D engineers with compliance-type testing

2. Advanced features: automatic fixture removal (AFR), differential TRL, multiport crosstalk

### Installation and Maintenance







#### Measurement challenges

Network analyzer measurements made in the field are fundamentally similar to measurements in the lab-users need to test S-parameters of devices such as cables and filters to determine their performance. The main difference is the requirements placed on the network analyzer hardware. Portability is a big challenge in the field. Carrying benchtop instruments on a cart or trying to fit a benchtop instrument in a tight space like an aircraft is difficult. Locating AC power can also be difficult, so a portable and battery-operated analyzer is often vital for field test. In addition, while indoor temperatures may be fairly stable, the weather conditions outdoors are quite variable, so the equipment has to be designed to handle these changes. Any VNA used outdoors also has to be rugged, as it is moved around often. Finally, the measurements made in the field need to match the measurements made in the lab, and have similar accuracy.

#### Our solutions

#### FieldFox analyzer family

- Designed for field use, battery operated, portable, display viewable in sunlight
- Completely sealed enclosure complaint with MIL-PRF-28800F Class 2 and type tested; meets IEC/EN 60529 requirements for ingress protection
- Large buttons are easy to operate even while wearing gloves
- Network analyzer-measure all four S-parameters, and perform calibrations such as full 2-port Cal and TRL; unique QuickCal for field calibration
- Optional spectrum analyzer and GPS receiver for interference analysis

#### M937xA PXI VNA Series

- Best PXI VNA performance on key specifications such as dynamic range, measurement speed, and trace noise
- Full two-port VNA that fits in just one slot
- Full N-port calibration support

#### E5061B RF ENA Series network analyzer

- Benchtop light weight model up to 3 GHz
- Suitable for measurements that require higher analog performance such as wide dynamic range or fast sweep speed

#### Installation and maintenance

Models				Features					
	Portability	Battery life	S-parameters	Frequency range	Dynamic range at 3 GHz	Full 2-port calibration	Time domain	Spectrum analyzer	SCPI programmable
FieldFox	6.6 lb/3 kg	3.5 hours	•	30/300 kHz to 4/6.5/9/14/18/26.5/32/44/50 GHz	95 dB	•	•	•	•
PXI VNA	1.3 lb/0.59 kg	N/A	٠	300 kHz to 4/6.5/9/ 14/20/26.5 GHz	115 dB	•	٠		•
E5061B RF	30 lb/14 kg	N/A	٠	100 kHz to 1.5/3 GHz	120 dB	٠	•		•

### Related Network Analyzer Products and Accessories



#### Electronic calibration (ECal) modules

PNA

ENA PXI VNA

FieldFox

ECal modules provide a precision, single-connection calibration technique for vector network analyzers. ECal modules are fully traceable and verifiable electronic impedance standards and can simplify your daily calibration routine. RF ECal modules are available for Type N-50, N-75, 7 mm, 3.5 mm, Type F, and 7-16 (300 kHz to 13.5 GHz) connectors. Modules are available in microwave frequency ranges from 300 kHz to 67 GHz for 7 mm, Type N-50, 3.5 mm, 2.92 mm, 2.4 mm and 1.85 mm. 4-port modules are available in 13.5 and 20 GHz frequency ranges.

#### Microwave test accessories

ENA PXI VNA PNA FieldFox

provides a complete series of coaxial and waveguide RF and microwave test accessories - everything from adapters, power limiters, DC blocks, attenu-ators, and couplers, to switches and system amplifiers. These test accessories complete your test solutions by simplifying test setups and maximizing the equip- ment's full potential to ensure the best possible measurement results.



PXI VNA up to 32-ports, multiport test set

E5080A ENA with

multiport test set

E5092A configurable



N5251A 110 GHz single sweep solution

#### Multiport/multi-site solutions

PNA

ENA PXI VNA

Whether you're measuring differential devices, highly integrated multiport components, or testing many 1-port devices, offers a variety of multiport/multisite solutions to suit your measurement needs and dramatically reduce test times.

#### Broadband and millimeter wave

The N5251A millimeter-wave system is a single-sweep solution from 10 MHz to 110 GHz with built-in Kelvin bias tees and 2- and 4-port S-parameter measurements. This is a direct replacement for the 8510XF and N5250C with improved performance. In particular, a new receiver-leveling function lets you set the source power accurately at the 1.0 mm test port. also offers a variety of banded millimeter-wave solutions that enable the PNA and PNA-X network analyzers to make S-parameter measurements up 1.1 THz.

PNA

### Related Network Analyzer Products and Accessories (continued)



Materials measurement

ENA FieldFox

Trust to deliver leading-edge techniques for measuring dielectric and magnetic properties of materials. The 85070E dielectric probe kit offers hardware and software for measuring complex permittivity of liquids and conformable solids from 200 MHz to 50 GHz. The 85071E materials measurement software automates a variety of techniques across a wide frequency span, including transmission-line, free-space and resonant-cavity methods. The 85072A 10 GHz split-cylinder resonator measures complex permittivity and loss tangent of thin films, un-clad substrates, and other low-loss sheet materials as part of a turnkey solution for IPC standard TM 650 2.5.5.13. Measuring electromagnetic properties of materials is critical in all stages of a products lifecycle: design, incoming inspection, process monitoring and quality assurance. sets the measurement standard with more than 20 years of experience and innovative new products.

PNA



N5264A PNA-X measurement receiver

#### Antenna receiver

Technologies provides many of the components you need to make accurate antenna and radar cross-section (RCS) measurements. The N5264A PNA-X measurement receiver is a dedicated antenna receiver with 400,000 point-per-second data acquisition on all five measurement channels. The N5264A provides twice as many receivers compared to any other antenna receiver on the market. The N5264A is compatible with MXG or PSG signal generators, the 85309B distributed frequency converter, and 85320A/B mixers. The receiver and an MXG source can completely replace the 8530A and 8360B sources for existing antenna ranges and typically results in a system-speed improvement that is 10 times faster. Additionally, the built-in 8510x/8530A code-emulation software provides a drop-in replacement for existing antenna ranges utilizing an 8530A. The N5264A is supported by major antenna-system integrators such as Microwave Vision Group, Nearfield Systems Inc., ETS-Lindgren, and the System Planning Corporation.



85541A 40 GHz temperature characterized CalPod

#### CalPod calibration-refresh modules

provides a new and unique way to quickly and easily refresh a calibration at the push of a button, without removing the DUT and without the physical con-nection of standards. CalPods are particularly useful in thermal or thermal-vacuum chambers for removing environmental effects from your measurement results due to temperature changes of cables, connectors, and adaptors, or for removing variations due to cable movements or variations in switch matrices.

PNA

# Key Performances and Functions Comparison

Mo	dels	Performances Dimension											
		Frequency	Dynam at 3 10	nic range (dB) /20 GHz at   Hz IFBW	Noise floor (dBm) at 3/20 GHz at 10 Hz IFBW	Max power at 3/20 GHz (dBM)	Best trace noise at 10 kHz <sup>1</sup> IFBW Mag (dBrms)/ Phase (degrms)	Best speed at 201 point 1sweep, correction off	H (mm) x W (mm) x D (mm), weight (kg)				
			System	Direct receiver access									
PNA-X	N5249A	10 MHz to 8.5 GHz	124–128/ 124–129	136–140/ 133–141	-114/-114	+8–13/ +5–10	0.0063/0.047	5 ms (600 kHz IFBW)	267 x 426 x 533, 27–37 kg				
	N5241A N5242A	10 MHz to 13.5 GHz 10 MHz to 26.5 GHz	124–128/ 124–129	136–140/ 133–141	-114/-114	+8–13/ +5–10	0.0063/0.047	5 ms (600 kHz IFBW)	267 x 426 x 533, 27–37 kg				
	N5244A N5245A	10 MHz to 43.5 GHz 10 MHz to 50 GHz	118–123/ 121–125	130–135/ 133–137	-110/-111	+8–13/ +10–14	0.0063/0.094	6 ms (600 kHz IFBW)	267 x 426 x 583, 47–49 kg				
	N5247A	10 MHz to 67 GHz	124–130/ 125–130	136–142/ 136–140	-115/-118	+9–15/ +7–12	0.0063/0.063	9.7 ms (600 kHz IFBW)	267 x 426 x 583, 47–49 kg				
PNA	N5221A N5222A	10 MHz to 13.5 GHz 10 MHz to 26.5 GHz	127/ 124–127	139/ 136–139	-114/-114	+13/ +10–13	0.0063/0.047	5.6 ms (600 kHz IFBW)	267 x 426 x 533, 27–37 kg				
	N5224A N5225A	10 MHz to 43.5 GHz 10 MHz to 50 GHz	125–127/ 124–127	137–139/ 136–139	-114/-114	+11–13/ +10–13	0.0095/0.063	4.7 ms (600 kHz IFBW)	267 x 426 x 582, 40–42 kg				
	N5227A	10 MHz to 67 GHz	127/ 124–127	138/ 135–138	-114/-116	+9–13/ +8–11	0.0063/0.063	6.3 ms (600 kHz IFBW)	267 x 426 x 583, 43–45 kg				
PNA-L	N5239A N5231A N5232A	300 kHz to 8.5 GHz 300 kHz to 13.5 GHz (N5231A Option 2xx) 300 kHz to 20 GHz (N5232A Option 2xx)	131–133/ 111–114	144/124	-120/-106	+11–13/ +5–8	0.012/0.19	5.75 ms (600 kHz IFBW)	267 x 426 x 446, 24 kg				
	N5231A N5232A	300 kHz to 13.5 GHz (N5231A Option 4xx) 300 kHz to 20 GHz (N5232A Option 4xx)	128/ 101–105	141/114	-120/-107	+8/ -6 -2	0.0063/0.063	5.75 ms (600 kHz IFBW)	267 x 426 x 446, 24 kg				
	N5234A N5235A	10 MHz to 43.5 GHz 10 MHz to 50 GHz	110/100	128/117	-110/-100	0/0	0.019/0.19	6 ms (600 kHz IFBW)	267 x 426 x 446, 25 kg				
ENA	E5080A	9 kHz to 4.5 GHz (Option 245/445) 9 kHz to 6.5 GHz (Option 265/465) 9 kHz to 9 GHz (Option 295/495)	135/		-130/	+15/	0.0015/0.01	2 ms (500 kHz IFBW)	267 x 426 x 488, 21-23 kg				
	E5072A	30 kHz to 4.5 GHz (Option 245) 30 kHz to 8.5 GHz (Option 285)	123/	151/	-117/	+16/	0.0015/0.013	3 ms (500 kHz IFBW)	222 x 426 x 496, 20 kg				
	E5071C	9 kHz to 4.5 GHz (Option 240, 440) 100 kHz to 4.5 GHz (Option 245, 445) 9 kHz to 6.5 GHz (Option 260, 460) 100 kHz to 6.5 GHz (Option 265, 465) 9 kHz to 8.5 GHz (Option 280, 480) 100 kHz to 8.5 GHz (Option 285, 485)	123/	NA	-123/	+10/	0.0011/0.013	3 ms (500 kHz IFBW)	222 x 426 x 487, 19–20 kg				
		300 kHz to 14 GHz (Option 2D5, 4D5) 300 kHz to 20 GHz (Option 2K5, 4K5)	123/96	NA	-123/-106	+10/0	0.0015/0.013	3 ms (500 kHz IFBW)	222 x 426 x 486, 20–22 kg				
	E5061B	5 Hz to 3 GHz (LF-RF Option 3L5, S-parameter, port) 100 kHz to 3 GHz (RF Option 135, 235, 137, 237) 100 kHz to 1.5 GHz (RF Option 115, 215, 117, 217)	120/	NA	-120/	+10/	0.0091/0.055	9 ms (300 kHz IFBW)	215 x 426 x 296, 14 kg				
	E5063A	100 kHz to 4.5 GHz (Option 245) 100 kHz to 8.5 GHz (Option 285) 100 kHz to 18 GHz (Option 2H5)	117/	NA	-127/	0/	0.0019/0.014	9 ms (300 kHz IFBW)	215 x 426 x 296, 11 kg				

# Key Performances and Functions Comparison (continued)

Mo	dels			Pe	erformances				Dimension
		Frequency	Dynam at 3, 10	iic range (dB) /20 GHz at Hz IFBW	Noise floor (dBm) at 3/20 GHz at 10 Hz IFBW	Max power at 3/20 GHz (dBM)	Best trace noise at 10 kHz <sup>1</sup> IFBW Mag (dBrms)/ Phase (degrms)	Best speed at 201 point 1sweep, correction off	H (mm) x W (mm) x D (mm), weight (kg)
			System	Direct receiver access			-		
PXI VNA	M9370A	300 kHz to 4 GHz	115/-	- / -	-108/-	+7/-	0.003/0.030	6 ms (600 kHz IFBW)	128.4 x 19.9 x 212.6, 0.59 kg
	M9371A	300 kHz to 6.5 GHz	115/-	-/-	-108/-	+7/-	0.003/0.030	6 ms (600 kHz IFBW)	128.4 x 19.9 x 212.6, 0.59 kg
	M9372A	300 kHz to 9 GHz	115/-	-/-	-108/-	+7/-	0.003/0.030	6 ms (600 kHz IFBW)	128.4 x 19.9 x 212.6, 0.59 kg
	M9373A	300 kHz to 14 GHz	115/-	- / -	-108/-	+7/-	0.003/0.030	6 ms (600 kHz IFBW)	128.4 x 19.9 x 212.6, 0.59 kg
	M9374A	300 kHz to 20 GHz	115/110	- / -	-108/-108	+7/+2	0.003/0.030	6 ms (600 kHz IFBW)	128.4 x 19.9 x 212.6, 0.59 kg
	M9375A	300 kHz to 26.5 GHz	115/110	- / -	-108/-108	+7/+2	0.003/0.030	6 ms (600 kHz IFBW)	128.4 x 19.9 x 212.6, 0.59 kg
FieldFox	N9913A N9914A N9915A N9916A N9917A N9918A	30 kHz to 4 GHz 30 kHz to 6.5 GHz 30 kHz to 9 GHz 30 kHz to 14 GHz 30 kHz to 18 GHz 30 kHz to 18 GHz	95/74 (300 Hz IFBW)	- / -	-/-	-1/-10	0.004/0.070 (300 Hz IFBW)	300 ms (10 kHz IFBW)	292 x 188 x 72, 3 kg
	N9950A N9951A N9952A	300 kHz to 32 GHz 300 kHz to 44 GHz 300 kHz to 50 GHz	100/102 (300 Hz IFBW)	-/-	-/-	Port 1: +2, port 2: 0 / Port 1: +1, port 2: -2	0.004/0.070 (300 Hz IFBW)	180 ms (10 kHz IFBW)	292 x 188 x 72, 3.2 kg

1. Calculated to normalize 10 kHz IFBW equivalent noise

### Key Performances and Functions Comparison (continued)

	Models	Features and functions											
		Sweep type	4-port test set option	Full N port cal option	Front jumpers for direct receiver access or high power handling	Built-in 2nd source option	Receiver attenuators option	Built-in bias tees	Frequency offset mode	Internal pulse modulator and generator	Built-in programing environment	Noise figure measurement option	Unique function/ feature
PNA-X	N5249A N5241A N5242A N5244A N5245A N5247A	Linear, Log, Segment, CW, Power,	•	•	•	٠	•	(Option)	•	•		(Standard and low-noise receiver)	Nonlinear vector network analyzer option Buillt-in combiner Up to 24 port external test set mm-wave support Spectrum analysis option
PNA	N5221A N5222A N5224A N5225A N5227A	- DC source, Phase	•	•	(Option)	•	•	(Option)	•	•		(Standard receiver)	Metrology option Up to 24 port external test set mm-wave support Spectrum analysis option
PNA-L	N5234A N5235A N5239A N5231A N5232A	Linear, Log, Segment, CW, Power, DC source	•1	•	(Option) (Option)				•				Up to 24 port external test set
ENA	E5080A E5072A E5071C E5061B LF-RF option E5061B RF option E5063A	Linear, Log, Segment, Power Linear, Log, Segment, Power, DC bias Linear, Log, Segment, Power Linear, Log, Segment	•		•			• (Option)	•		•		Modern GUI         Up to 22 port external         test set         Deep extended dynamic range         as 151 dB (SPD)         TDR option         Up to 22 port external test set         Gain-phase port         (5 Hz to 30 MHz)         Impedance analysis         (Option 005)         Built-in DC bias source         75 Ω test set option         T/R test set option         PCB manufacturing test
PXI VNA	M9370A M9371A M9372A M9373A M9374A M9375A	Linear, Log, Segment, CW, Power	• 2	•							• 3		Multiport up to 32 ports, multi-site, modular
FieldFox	N9913A N9914A N9915A N9916A N9917A N9918A N9950A N9951A N9952A Microwave (combination) analyzers <sup>4</sup>	Linear											Handheld Spectrum analysis option T/R test set (Option 210) Full 2-port S-parameters (Option 211) Mixed mode S-parameters (Option 212)

N5231A and N5232A only.
 Add additional modules to increase number of ports.

Programming capability is available in the PXIe embedded or external controller.
 Combination analyzer = Cable and antenna tester (CAT) + Vector network analyzer (VNA) + Spectrum analyzer (SA)

### Migration and Upgrades

Carefully planned instrument migration and modernization can maximize your test-system efficiency, performance, and readiness, while minimizing risk and potential disruptions, keeping you at the leading edge in the competitive market-place. PNA, ENA, PXI VNA, and FieldFox are perfect replacements to their predecessors. Take advantage of the latest VNAs' advanced performance and modern functions when replacing the legacy network analyzers.



#### Premium trade-in solutions

In many countries, offers a variety of trade-in solutions to give you advanced measurement capabilities, increased throughput and greater reliability—for less than list price.





#### Protect your VNA investment

offers various VNA hardware and software upgrades to meet your future measurement needs. Keysight's cXL code-translation software can also help you run your legacy 8753, 8720, and 8510 remote programs while controlling the latest VNAs.

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